

ONET8501P SLLS885-FEBRUARY 2008

# 11.3-Gbps RATE-SELECTABLE LIMITING AMPLIFIER

## FEATURES

- Up to 11.3-Gbps Operation
- 2-Wire Digital Interface
- Digitally Selectable Input Bandwidth
- Adjustable LOS Threshold
- Digitally Selectable Output Voltage
- Digitally Selectable Output Pre-Emphasis
- Adjustable Input Threshold Voltage
- Low Power Consumption
- Input Offset Cancellation
- CML Data Outputs with On-Chip 50-Ω Back-Termination to VCC
- Single +3.3-V Supply

- Output Disable
- Surface Mount Small Footprint 3 mm × 3 mm 16-Pin RoHS compliant QFN Package

## APPLICATIONS

- 10-Gigabit Ethernet Optical Receivers
- 8x and 10x Fiber Channel Optical Receivers
- SONET OC-192/SDH-64 Optical Receivers
- SFP+ and XFP Transceiver Modules
- XENPAK, XPAK, X2 and 300-pin MSA Transponder Modules
- Cable Driver and Receiver

## DESCRIPTION

The ONET8501P is a high-speed, 3.3-V limiting amplifier for multiple fiber optic and copper cable applications with data rates from 2 Gbps up to 11.3 Gbps.

The device provides a two-wire serial interface which allows digital control of the bandwidth, output amplitude, output pre-emphasis, input threshold voltage (slice level) and the loss of signal assert level. Predetermined settings for bandwidth and LOS assert levels can also be selected with external rate selection pins.

The ONET8501P provides a gain of about 40dB which ensures a fully differential output swing for input signals as low as 10 mV<sub>pp</sub>. The output amplitude can be adjusted to 300 mV<sub>pp</sub>, 600 mV<sub>pp</sub>, or 900 mV<sub>pp</sub>. To compensate for frequency dependent loss of microstrips or striplines connected to the output of the device, programmable pre-emphasis is included in the output stage. A settable loss of signal detection and output disable are also provided.

The part, available in RoHS compliant small footprint 3 mm  $\times$  3 mm 16-pin QFN package, typically dissipates less than 160 mW and is characterized for operation from –40°C to 100°C.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## **BLOCK DIAGRAM**

A simplified block diagram of the ONET8501P is shown in Figure 1.

This compact, low power 11.3 Gbps limiting amplifier consists of a high-speed data path with offset cancellation block (DC feedback) combined with an analog settable input threshold adjust, a loss of signal detection block using 2 peak detectors, a two-wire interface with a control-logic block and a bandgap voltage reference and bias current generation block.

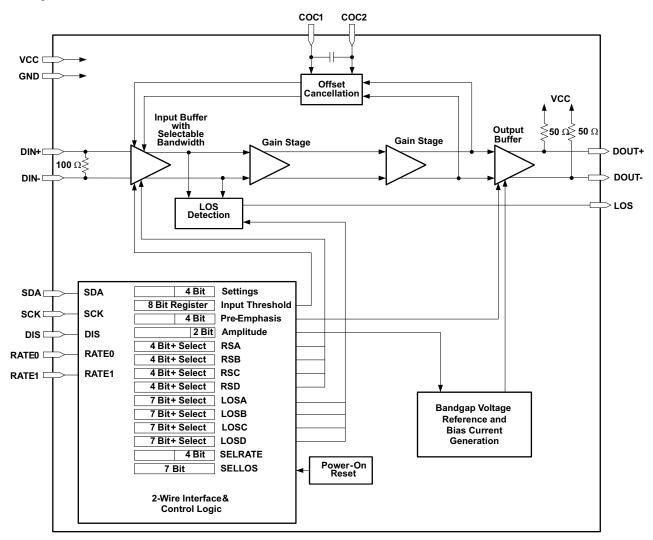


Figure 1. Simplified Block Diagram of the ONET8501P

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## PACKAGE

The ONET8501P is available in a small footprint 3 mm  $\times$  3 mm 16-pin RoHS compliant QFN package with a lead pitch of 0,5 mm. The pin out is shown in Figure 2.

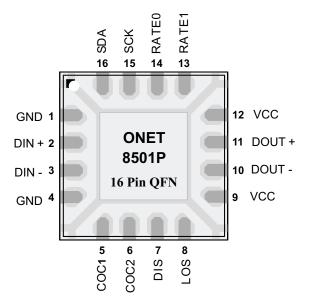


Figure 2. Pinout of ONET8501P in a 3mm × 3mm 16-Pin QFN package (top view)

#### **PIN DESCRIPTION**

NO.	NAME	TYPE	DESCRIPTION	
1,4, EP	GND	Supply	Circuit ground. Exposed die pad (EP) must be grounded.	
2	DIŅ+	Analog-input	Non-inverted data input. Differentially 100 $\Omega$ terminated to DIN–.	
3	DIN-	Analog-input	Inverted data input. Differentially 100 $\Omega$ terminated to DIN+.	
5	COC1	Analog	Offset cancellation filter capacitor plus terminal. An external capacitor can be connected between this pin and COC2 to reduce the low frequency cutoff. To disable the offset cancellation loop, connect COC1 and COC2 together.	
6	COC2	Analog	Offset cancellation filter capacitor minus terminal. An external capacitor can be connected between this pin and COC1 to reduce the low frequency cutoff. To disable the offset cancellation loop, connect COC1 and COC2 together.	
7	DIS	Digital-input	Disables the output stage when set to a high level.	
8	LOS	Open drain MOS	High level indicates that the input signal amplitude is below the programmed threshold level. Open drain output. Requires an external $10-k\Omega$ pull-up resistor to VCC for proper operation.	
9, 12	VCC	Supply	3.3-V ± 10% supply voltage.	
10	DOUT-	CML-out	Inverted data output. On-chip 50 $\Omega$ back-terminated to VCC.	
11	DOUT+	CML-out	Non-inverted data output. On-chip 50 $\Omega$ back-terminated to VCC.	
13	RATE1	Digital-input	Bandwidth selection for noise suppression.	
14	RATE0	Digital-input	Bandwidth selection for noise suppression.	
15	SCK	Digital-input	Serial interface clock input. Connect a pull-up resistor (10 k $\Omega$ typical) to VCC.	
16	SDA	Digital-input	Serial interface data input. Connect a pull-up resistor (10 kΩ typical) to VCC.	

## **ONET8501P**

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## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

		VALUE	UNIT
V <sub>CC</sub>	Supply voltage <sup>(2)</sup>	-0.3 to 4.0	V
V <sub>DIN+</sub> , V <sub>DIN-</sub>	Voltage at DIN+, DIN- <sup>(2)</sup>	0.5 to 4.0	V
V <sub>LOS</sub> , V <sub>COC1</sub> , V <sub>COC2</sub> , V <sub>DOUT+</sub> , V <sub>DOUT-</sub> , V <sub>DIS</sub> , V <sub>RATE0</sub> , V <sub>RATE1</sub> , V <sub>SDA</sub> , V <sub>SCK</sub>	Voltage at LOS, COC1, COC2, DOUT+, DOUT-, DIS, RATE0, RATE1, SDA, SCK <sup>(2)</sup>	-0.3 to 4.0	V
V <sub>DIN,DIFF</sub>	Differential voltage between DIN+ and DIN-	±2.5	V
I <sub>DIN+</sub> , I <sub>DIN-</sub> , I <sub>DOUT+</sub> , I <sub>DOUT-</sub>	Continuous current at inputs and outputs	25	mA
ESD	ESD rating at all pins	2	kV (HBM)
T <sub>J,max</sub>	Maximum junction temperature	125	°C
T <sub>A</sub>	Characterized free-air operating temperature range	-40 to 100	°C
T <sub>STG</sub>	Storage temperature range	-65 to 150	°C
T <sub>LEAD</sub>	Lead temperature 1.6mm (1/16 inch) from case for 10 seconds	260	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Device exposure to conditions outside the Absolute Maximum Ratings ranges for an extended duration can affect device reliability.

(2) All voltage values are with respect to network ground terminal.

### **RECOMMENDED OPERATING CONDITIONS**

		MIN	TYP	MAX	UNIT
V <sub>CC</sub>	Supply voltage	2.95	3.3	3.6	V
T <sub>A</sub>	Operating free-air temperature	-40		100	°C
	DIGITAL input high voltage	2.0			V
	DIGITAL input low voltage			0.8	V

## DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, outputs connected to a 50- $\Omega$  load, AMP1 = 0, AMP0 = 1 (Register 3) unless otherwise noted. Typical operating condition is at V<sub>CC</sub> = 3.3 V and T<sub>A</sub> = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2.95	3.3	3.6	V
I <sub>VCC</sub>	Supply current	DIS = 0, CML currents included		48	61	mA
R <sub>IN</sub>	Data input resistance	Differential		100		Ω
R <sub>OUT</sub>	Data output resistance	Single-ended, referenced to V <sub>CC</sub>		50		Ω
	LOS HIGH voltage	$I_{SOURCE}$ = 50 µA with 10 k $\Omega$ pull-up to V <sub>CC</sub>	2.4			
	LOS LOW voltage	$I_{SINK}$ = 10 mA with 10 k $\Omega$ pull-up to V <sub>CC</sub>			0.4	V

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## AC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions, outputs connected to a 50- $\Omega$  load, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted. Typical operating condition is at V<sub>CC</sub> = 3.3 V and T<sub>A</sub> = +25°C

	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
f <sub>3dB-H</sub>	High frequency -3dB bandwidth		8.5	12.0		GHz
f <sub>3dB-H</sub>	–3dB bandwidth default settings	RATE1 = 1, RATE0 = 0		11.0		GHz
		RATE1 = 1, RATE0 = 1		6.5		
		RATE1 = 0, RATE0 = 1		4.0		
		RATE1 = 0, RATE0 = 0		2.2		
f <sub>3dB-L</sub>	Low frequency –3dB bandwidth	With 330-pF COC capacitor		20	45	kHz
V <sub>IN,MIN</sub>	Data input sensitivity	K28.5 pattern at 11.3 Gbps, BER < 10 <sup>-12</sup>		6	9	$\mathrm{mV}_{\mathrm{pp}}$
		VOD-min ≥ 0.95 * VOD (output limited)		8	20	
		K28.5 pattern at 8.5 Gbps, BER < 10 <sup>-12</sup> , RATE1 = 1, RATE0 = 0		5.5		
		K28.5 pattern at 4.25 Gbps, BER < 10 <sup>-12</sup> , RATE1 = 1, RATE0 = 1		5		
		K28.5 pattern at 2.125 Gbps, BER < 10 <sup>-12</sup> , RATE1 = 0, RATE0 = 1		5		
SDD11	Differential input return gain	0.01 GHz < f < 3.9 GHz		-16		dB
00011	Difformatin patrotain gain	3.9 GHz < f < 12.1 GHz		See <sup>(1)</sup>		üÐ
SDD22	Differential output return gain	0.01 GHz < f < 3.9 GHz		-16		dB
ODDZZ	Diferential output return gain	3.9 GHz < f < 12.1 GHz		See <sup>(1)</sup>		üD
SCD11	Differential to common mode	0.01 GHz < f < 12.1 GHz		-40		dB
SCDTT	conversion gain			-40		uВ
SCC22	Common mode output return gain	0.01 GHz < f < 7.5 GHz		-13		dB
		7.5 GHz < f < 12.1 GHz	-9			
A	Small signal gain 35		40		dB	
V <sub>IN,MAX</sub>	Data input overload		2000			mV <sub>pp</sub>
DJ	Deterministic jitter at 11.3 Gbps	v <sub>IN</sub> = 5 mV <sub>pp</sub> , K28.5 pattern		5	10	ps <sub>pp</sub>
		$v_{IN} = 20 \text{ mV}_{pp}$ , K28.5 pattern		4	10	1 66
		$v_{IN} = 2000 \text{ mV}_{DD}$ , K28.5 pattern		5	15	
	Deterministic jitter at 8.5 Gbps	$v_{IN} = 20 \text{ mV}_{pp}$ , K28.5 pattern, RATE1 = 1, RATE0 = 0		5		ps <sub>pp</sub>
	Deterministic jitter at 4.25 Gbps	$v_{IN} = 20 \text{ mV}_{pp}$ , K28.5 pattern, RATE1 = 1, RATE0 = 1		6		ps <sub>pp</sub>
	Deterministic jitter at 2.125 Gbps	$v_{IN} = 20 \text{ mV}_{pp}$ , K28.5 pattern, RATE1 = 0, RATE0 = 1		10		ps <sub>pp</sub>
RJ	Random jitter	$v_{IN} = 20 \text{ mVpp}$		1		ps <sub>rms</sub>
V <sub>OD</sub>	Differential data output voltage	$v_{IN} > 20 \text{ mV}_{pp}$ , DIS = 0, AMP1 = 0, AMP0 = 0	250	300	350	mV <sub>pp</sub>
•00		$v_{IN} > 20 \text{ mV}_{pp}$ , DIS = 0, AMP1 = 0, AMP0 = 1	500	600	700	···· pp
		$v_{IN} > 20 \text{ mV}_{pp}$ , DIS = 0, AMP1 = 1, AMP0 = 1	700	900	1100	
		$V_{IN} > 20 \text{ mV}_{pp}, DIS = 0, AWI T = 1, AWI O = 1$ DIS = 1	700	300	5	mV <sub>rms</sub>
V <sub>PREEM</sub>	Output pre-emphasis step size			1	5	dB
		20% to $80%$ V > $20m$ Vpp		25	35	
t <sub>R</sub>	Output rise time	20% to 80%, v <sub>IN</sub> > 20mVpp			35 35	ps
t <sub>F</sub>	Output fall time	20% to 80%, v <sub>IN</sub> > 20mVpp		25	35	ps
V <sub>TH</sub>	LOW LOS assert threshold range min	K28.5 pattern at 11.3 Gbps, LOSRNG = 0		15		mV <sub>pp</sub>
	LOW LOS assert threshold range max	K28.5 pattern at 11.3 Gbps, LOSRNG = 0		35		
$V_{\text{TH}}$	HIGH LOS assert threshold range min	K28.5 pattern at 11.3 Gbps, LOSRNG = 1		35		$\mathrm{mV}_{\mathrm{pp}}$
	HIGH LOS assert threshold range max	K28.5 pattern at 11.3 Gbps, LOSRNG = 1		80		
	LOS threshold variation	Versus temperature at 11.3 Gbps		1.5		dB
		Versus supply voltage V <sub>CC</sub> at 11.3 Gbps		1		dB
		Versus data rate		1.5		dB
	LOS hysteresis (electrical)	K28.5 pattern at 11.3 Gbps	2	4	6	dB
TLOS AST	LOS assert time		2.5	10	80	us
TLOS DEA	LOS deassert time		2.5	10	80	us

(1) Differential return gain given by SDD11, SDD22 =  $-11.6 + 13.33 \log_{10}(f/8.25)$ , f expressed in GHz.

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## AC ELECTRICAL CHARACTERISTICS (continued)

Over recommended operating conditions, outputs connected to a 50- $\Omega$  load, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted. Typical operating condition is at V<sub>CC</sub> = 3.3 V and T<sub>A</sub> = +25°C

	PARAMETER	TEST CONDITION	MIN	TYP	MAX	UNIT
T <sub>DIS</sub>	Disable response time			20		ns

## DETAILED DESCRIPTION

#### HIGH-SPEED DATA PATH

The high-speed data signal is applied to the data path by means of input signal pins DIN+/DIN–. The data path consists of a 100- $\Omega$  differential on-chip line termination resistor followed by a digitally controlled bandwidth switch input buffer for rate select. The RATE1 and RATE0 pins can be used to control the bandwidth of the filter. Default bandwidth settings are used; however, these can be changed using registers 4 through 7 via the serial interface. For details regarding the rate selection, see Table 19. A gain stage and an output buffer stage follow the input buffer, which together provide a gain of 40dB. The device can accept input amplitude levels from 5 mV<sub>pp</sub> up to 2000 mV<sub>pp</sub>. The amplified data output signal is available at the output pins DOUT+/DOUT– which include on-chip 2 × 50- $\Omega$  back-termination to VCC.

Offset cancellation compensates for internal offset voltages and thus ensures proper operation even for very small input data signals. The offset cancellation can be disabled so that the input threshold voltage can be adjusted to optimize the bit error rate or change the eye crossing to compensate for input signal pulse width distortion. The offset cancellation can be disabled by setting OCDIS = 1 (bit 1 of register 0). The input threshold adjust, see Table 19.

The low frequency cutoff is as low as 80 kHz with the built-in filter capacitor. For applications, which require even lower cutoff frequencies, an additional external filter capacitor may be connected to the COC1 and COC2 pins. A value of 330 pF results in a low frequency cutoff of 20 kHz.

#### BANDGAP VOLTAGE AND BIAS GENERATION

The ONET8501P limiting amplifier is supplied by a single +3.3-V supply voltage connected to the VCC pins. This voltage is referred to ground (GND).

On-chip bandgap voltage circuitry generates a reference voltage, independent of supply voltage, from which all other internally required voltages and bias currents are derived.

#### HIGH-SPEED OUTPUT BUFFER

The output amplitude of the buffer can be set to 300 mV<sub>pp</sub>, 600 mV<sub>pp</sub> or 900 mV<sub>pp</sub> using register settings AMP[0..1] (register 3) via the serial interface. To compensate for frequency dependant losses of transmission lines connected to the output, the ONET8501P has adjustable pre-emphasis of the output stage. The pre-emphasis can be set from 0 to 8 dB in 1 dB steps using register settings PEADJ[0..3] (register 2).

#### RATE SELECT

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There are 16 possible internal filter settings (4 bit) to adjust the small signal bandwidth to the data rate. For fast rate selection, 4 default values can be selected with the RATE1 and RATE0 pins. Using the serial interface, the bandwidth settings can be customized instead of using the default values. The default bandwidths and the registers used to change the bandwidth settings are shown in Table 1.

RATE1	RATE0	DEFAULT BANDWIDTH (GHz)	REGISTER USED FOR ADJUSTMENT
0	0	2.2	RSA (Register 4)
0	1	4.0	RSB (Register 5)
1	1	6.5	RSC (Register 6)
1	0	11.0	RSD (Register 7)

#### Table 1. Rate Selection Default Settings and Registers Used for Adjustment

If the rate select register selection bit is set LOW, for example RSASEL = 0 (bit 7 of register 4), then the default bandwidth for that register is used. If the register selection bit is set HIGH, for example RSASEL = 1 (bit 7 of register 4), then the content of RSA[0..3] (register 4) is used to set the input filter bandwidth when RATE0 = 0 and RATE1 = 0. The settings of the rate selection registers RSA, RSB, RSC and RSD and the corresponding filter bandwidths are shown in Table 2.

RSX3	RSX2	RSX1	RSX0	TYPICAL BANDWIDTH (GHz)
0	0	0	0	12.0
0	0	0	1	11.5
0	0	1	0	11.0
0	0	1	1	10.0
0	1	0	0	8.6
0	1	0	1	6.5
0	1	1	0	5.2
0	1	1	1	4.3
1	0	0	0	4.0
1	0	0	1	3.7
1	0	1	0	3.3
1	0	1	1	2.9
1	1	0	0	2.7
1	1	0	1	2.5
1	1	1	0	2.3
1	1	1	1	2.2

The RATE1 and RATE0 pins do not have to be used if the serial interface is being used. If RATE1 is not connected it is internally pulled HIGH and if RATE0 is not connected it is internally pulled LOW, thus selecting register 7. Therefore, changing the contents of RSD[0..3] (register 7) through the serial interface can be used to adjust the bandwidth.

## LOSS OF SIGNAL DETECTION

The loss of signal detection is done by 2 separate level detectors to cover a wide dynamic range. The peak values of the input signal and the output signal of the gain stage are monitored by the peak detectors. The peak values are compared to a pre-defined loss of signal threshold voltage inside the loss of signal detection block. As a result of the comparison, the LOS signal, which indicates that the input signal amplitude is below the defined threshold level, is generated. The LOS assert level is settable through the serial interface. There are 2 LOS ranges settable with the LOSRNG bit (bit 2, register 0) via the serial interface. By setting the bit LOSRNG = 1, the high range of the LOS assert values are used ( $35 \text{ mV}_{pp}$  to  $80 \text{ mV}_{pp}$ ) and by setting the bit LOSRNG = 0, the low range of the LOS assert values are used ( $15 \text{ mV}_{pp}$  to  $35 \text{ mV}_{pp}$ ).

There are 128 possible internal LOS settings (7 bit) for each LOS range to adjust the LOS assert level. For fast LOS selection, 4 default values can be selected with the RATE1 and RATE0 pins; however, the LOS settings can be customized instead of using the default values. The default LOS assert levels and the registers used to change the LOS settings are shown in Table 3.

RATE1	RATE0	DEFAULT LOS ASSERT LEVEL (mV <sub>pp</sub> )	REGISTER USED FOR ADJUSTMENT
0	0	15	LOSA (Register 8)
0	1	18	LOSB (Register 9)
1	1	26	LOSC (Register 10)
1	0	26	LOSD (Register 11)



If the LOS register selection bit is set LOW, for example LOSASEL = 0 (bit 7, register 8), then the default LOS assert level for that register is used. If the register selection bit is set HIGH, for example LOSASEL = 1 (bit 7, register 8), then the content of LOSA[0..6] (register 8) is used to set the LOS assert level when RATE1 = 0 and RATE0 = 0. The RATE1 and RATE0 pins do not have to be used if the serial interface is being used. If RATE1 is not connected it is internally pulled HIGH and if RATE0 is not connected it is internally pulled LOW, thus selecting register 11. Therefore, changing the contents of LOSD[0..6] (register 11) through the serial interface can be used to adjust the LOS assert level.

## 2-WIRE INTERFACE AND CONTROL LOGIC

The ONET8501P uses a 2-wire serial interface for digital control. The two circuit inputs, SDA and SCK, are driven, respectively, by the serial data and serial clock from a microcontroller, for example. Both inputs include  $100-k\Omega$  pull-up resistors to VCC. For driving these inputs, an open drain output is recommended.

The 2-wire interface allows write access to the internal memory map to modify control registers and read access to read out control and status signals. The ONET8501P is a slave device only which means that it can not initiate a transmission itself; it always relies on the availability of the SCK signal for the duration of the transmission. The master device provides the clock signal as well as the START and STOP commands. The protocol for a data transmission is as follows:

- 1. START command
- 2. 7-bit slave address (1000100) followed by an eighth bit which is the data direction bit (R/W). A zero indicates a WRITE and a 1 indicates a READ.
- 3. 8-bit register address
- 4. 8-bit register data word
- 5. STOP command

Regarding timing, the ONET8501P is  $I^2C$  compatible. The typical timing is shown in Figure 3 and a complete data transfer is shown in Figure 4. Parameters for Figure 3 are defined in Table 4.

Bus Idle: Both SDA and SCK lines remain HIGH

**Start Data Transfer:** A change in the state of the SDA line, from HIGH to LOW, while the SCK line is HIGH, defines a START condition (S). Each data transfer begins with a START condition.

**Stop Data Transfer:** A change in the state of the SDA line from LOW to HIGH while the SCK line is HIGH defines a STOP condition (P). Each data transfer ends with a STOP condition; however, if the master still wishes to communicate on the bus, it can generate a repeated START condition and address another slave without first generating a STOP condition.

**Data Transfer:** Only one data byte can be transferred between a START and a STOP condition. The receiver acknowledges the transfer of data.

Acknowledge: Each receiving device, when addressed, is obliged to generate an acknowledgment bit. The transmitter releases the SDA line and a device that acknowledges, must pull down the SDA line during the acknowledge clock pulse simultaneously so the SDA line is stable LOW during the HIGH period of the acknowledge clock pulse. Set-up and hold times must be taken into account. When a slave-receiver fails to acknowledge the slave address, the data line must be left HIGH by the slave. The master can generate a STOP condition to prevent the transfer. If the slave-receiver does acknowledge the slave address but some time later in the transfer cannot receive any more data bytes, the master must cancel the transfer. This is indicated by the slave generating the not acknowledge on the first following byte. The slave leaves the data line HIGH and the master generates the STOP condition.

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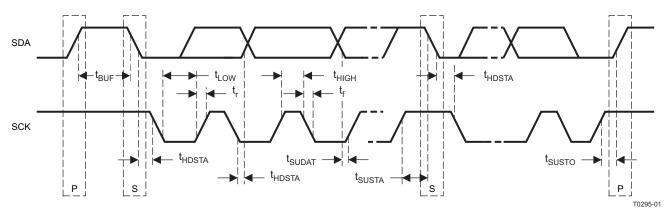


Figure 3. I<sup>2</sup>C Timing Diagram

Table 4.	Timing	Diagram	Definitions
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	PARAMETER	MIN	MAX	UNIT
f <sub>SCK</sub>	SCK clock frequency		400	kHz
t <sub>BUF</sub>	Bus free time between START and STOP conditions	1.3		μs
t <sub>HDSTA</sub>	Hold time after repeated START condition. After this period, the first clock pulse is generated	0.6		μs
t <sub>LOW</sub>	Low period of the SCK clock	1.3		μs
t <sub>HIGH</sub>	High period of the SCK clock	0.6		μs
t <sub>SUSTA</sub>	Setup time for a repeated START condition	0.6		μs
t <sub>HDDAT</sub>	Data HOLD time	0		μs
t <sub>SUDAT</sub>	Data setup time	100		ns
t <sub>R</sub>	Rise time of both SDA and SCK signals		300	ns
t <sub>F</sub>	Fall time of both SDA and SCK signals		300	ns
t <sub>SUSTO</sub>	Setup time for STOP condition	0.6		μs

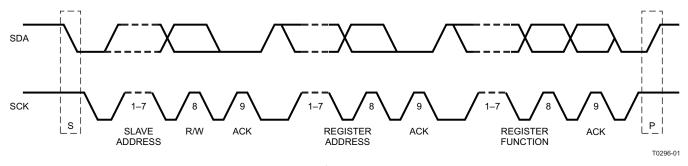


Figure 4. I<sup>2</sup>C Data Transfer

## **REGISTER MAPPING**

The register mapping for read/write register addresses 0 (0x00) through 11 (0x0B) are shown in Table 5 through Table 16. The register mapping for the read only register addresses 14 (0x0E) and 15 (0x0F) are shown in Table 17 and Table 18.

Table 19 describes the circuit functionality based on the register settings.



#### Table 5. Register 0 (0x00) Mapping – Control Settings

register address 0 (0x00)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0			
_	-	-	-	DIS	LOSRNG	OCDIS	I2CDIS			

#### Table 6. Register 1 (0x01) Mapping – Input Threshold Adjust

	register address 1 (0x01)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
THADJ7	THADJ6	THADJ5	THADJ4	THADJ3	THADJ2	THADJ1	THADJ0				

#### Table 7. Register 2 (0x02) Mapping – Pre-emphasis Adjust

	register address 2 (0x02)											
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0					
_	-	-	-	PEADJ3	PEADJ2	PEADJ1	PEADJ0					

#### Table 8. Register 3 (0x03) Mapping – Output Amplitude Adjust

	register address 3 (0x03)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
_	-	-	-	-	-	AMP1	AMP0				

#### Table 9. Register 4 (0x04) Mapping – Rate Selection Register A

	register address 4 (0x04)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
RSASEL	-	-	-	RSA3	RSA2	RSA1	RSA0				

#### Table 10. Register 5 (0x05) Mapping – Rate Selection Register B

	register address 5 (0x05)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
RSBSEL	_	-	-	RSB3	RSB2	RSB1	RSB0				

#### Table 11. Register 6 (0x06) Mapping – Rate Selection Register C

	register address 6 (0x06)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
RSCSEL	-	-	-	RSC3	RSC2	RSC1	RSC0				

#### Table 12. Register 7 (0x07) Mapping – Rate Selection Register D

	register address 7 (0x07)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
RSDSEL	_	_	_	RSD3	RSD2	RSD1	RSD0				

#### Table 13. Register 8 (0x08) Mapping – LOS Assert Level Register A

	register address 8 (0x08)											
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0					
LOSASEL	LOSA6	LOSA5	LOSA4	LOSA3	LOSA2	LOSA1	LOSA0					

	· · · · · · · · · · · · · · · · · · ·											
register address 9 (0x09)												
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0					
LOSBSEL	LOSB6	LOSB5	LOSB4	LOSB3	LOSB2	LOSB1	LOSB0					

#### Table 14. Register 9 (0x09) Mapping – LOS Assert Level Register B

#### Table 15. Register 10 (0x0A) Mapping – LOS Assert Level Register C

	register address 10 (0x0A)										
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0				
LOSCSEL	LOSC6	LOSC5	LOSC4	LOSC3	LOSC2	LOSC1	LOSC0				

#### Table 16. Register 11 (0x0B) Mapping – LOS Assert Level Register D

register address 11 (0x0B)													
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0						
LOSDSEL	LOSD6	LOSD5	LOSD4	LOSD3	LOSD2	LOSD1	LOSD0						

#### Table 17. Register 14 (0x0E) Mapping – Selected Rate Setting (Read Only)

	register address 14 (0x0E)												
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0						
-	-	-	-	SELRATE3	SELRATE2	SELRATE1	SELRATE0						

#### Table 18. Register 15 (0x0F) Mapping – Selected LOS Level (Read Only)

	register address 15 (0x0F)													
bit 7	bit 6	bit 5	bit4	bit 3	bit 2	bit 1	bit 0							
_	SELLOS6	SELLOS5	SELLOS4	SELLOS3	SELLOS2	SELLOS1	SELLOS0							

#### Table 19. Register Functionality

SYMBOL	REGISTER BIT	FUNCTION
DIS	Output disable bit 3	Output disable bit: 1 = output disabled 0 = output enabled
LOSRNG	LOS Range bit 2	LOS range bit: 1 = high LOS assert voltage range 0 = low LOS assert voltage range
OCDIS	Offset cancellation disable bit 1	Offset cancellation disable bit: 1 = offset cancellation is disabled 0 = offset cancellation is enabled
I2CDIS	I <sup>2</sup> C disable bit 0	<b>I<sup>2</sup>C disable bit:</b> $1 = I^2C$ is disabled. $0 = I^2C$ is enabled. This is the default setting.
THADJ7	Input threshold adjust bit 7 (MSB)	Input threshold adjustment setting:
THADJ6	Input threshold adjust bit 6	Maximum positive sift for 00000001 (1)
THADJ5	Input threshold adjust bit 5	Minimum positive shift for 01111111 (127)
THADJ4	Input threshold adjust bit 4	Zero shift for 10000000 (128)
THADJ3	Input threshold adjust bit 3	Minimum negative shift for 10000001 (129)
THADJ2	Input threshold adjust bit 2	Maximum negative shift for 1111111 (255)
THADJ1	Input threshold adjust bit 1	
THADJ0	Input threshold adjust bit 0 (LSB)	

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## Table 19. Register Functionality (continued)

SYMBOL	REGISTER BIT	FL	JNCTION
PEADJ3	Pre-emphasis adjust bit 3 (MSB)	Pre-emphasis setting:	
PEADJ2	Pre-emphasis adjust bit 2	Pre-emphasis (dB)	Register Setting
PEADJ1	Pre-emphasis adjust bit 1	0	0000
PEADJ0	Pre-emphasis adjust bit 0 (LSB)	1	0001
		2	0011
		3	0100
		4	0101
		5	0111
		6	1100
		7	1101
		8	1111
AMP1	Output amplitude adjustment bit 1	Output amplitude adjustment:	
AMP0	Output amplitude adjustment bit 0	$00 = 300 \text{ mV}_{pp}$	
		$01 = 600 \text{ mV}_{\text{pp}}$	
		$10 = 600 \text{ mV}_{pp}$	
		$11 = 900 \text{ mV}_{pp}$	
RSASEL	Register RSA select bit 7 (MSB)	Rate selection register A	
_		RSASEL = 1	
-		Content of register A bits 3 to 0 is	used to select the input filter BW
-		RSASEL = 0	
RSA3	Rate select register A bit 3	Default BW of 2.2 GHz is used	
RSA2	Rate select register A bit 2		
RSA1	Rate select register A bit 1	Register RSA is used when RATE1 =	0  and  RATE0 = 0
RSA0	Rate select register A bit 0 (LSB)		
RSBSEL	Register RSA select bit 7 (MSB)	Rate selection register B	
_		RSBSEL = 1	
_		Content of register B bits 3 to 0 is	s used to select the input filter BW
_		RSBSEL = 0	
RSB3	Rate select register B bit 3	Default BW of 4.0 GHz is used	
RSB2	Rate select register B bit 2		
RSB1	Rate select register B bit 1	Register RSB is used when RATE1 =	0 and RATE0 = 1
RSB0	Rate select register B bit 0 (LSB)		
RSCSEL	Register RSA select bit 7 (MSB)	Rate selection register C	
-		RSCSEL = 1	
-		Content of register C bits 3 to 0 is	s used to select the input filter BW
-		RSCSEL = 0	
RSC3	Rate select register C bit 3	Default BW of 6.5GHz is used	
RSC2	Rate select register C bit 2		
RSC1	Rate select register C bit 1	Register RSC is used when RATE1 =	1 and RATE0 = 1
RSC0	Rate select register C bit 0 (LSB)		

SYMBOL	REGISTER BIT	FUNCTION
RSDSEL	Register RSD select bit 7 (MSB)	Rate selection register D
_		RSDSEL = 1
_		Content of register D bits 3 to 0 is used to select the input filter BW
_		RSDSEL = 0
RSD3	Rate select register D bit 3	Default BW of 11.0 GHz is used
RSD2	Rate select register D bit 2	
RSD1	Rate select register D bit 1	Register RSD is used when RATE1 = 1 and RATE0 = 0 or RATE1 and RATE0 are
RSD0	Rate select register D bit 0 (LSB)	not connected
LOSASEL	Register LOSA select bit 7 (MSB)	LOS assert level register A
LOSA6	LOS assert level register A bit 6	LOSASEL = 1
LOSA5	LOS assert level register A bit 5	Content of register A bits 6 to 0 is used to select the LOS assert level
LOSA4	LOS assert level register A bit 4	Minimum LOS assert level for 0000000
LOSA3	LOS assert level register A bit 3	Maximum LOS assert level for 1111111
LOSA2	LOS assert level register A bit 2	LOSASEL = 0
LOSA1	LOS assert level register A bit 1	Default LOS assert level of 15 mVpp is used
LOSA0	LOS assert level register A bit 0 (LSB)	Register LOSA is used when RATE1 = 0 and RATE0 = 0
LOSBSEL	Register LOSB select bit 7 (MSB)	LOS assert level register B
LOSB6	LOS assert level register B bit 6	LOSBSEL = 1
LOSB5	LOS assert level register B bit 5	Content of register B bits 6 to 0 is used to select the LOS assert level
LOSB4	LOS assert level register B bit 4	Minimum LOS assert level for 0000000
LOSB3	LOS assert level register B bit 3	Maximum LOS assert level for 1111111
LOSB2	LOS assert level register B bit 2	LOSBSEL = 0
LOSB1	LOS assert level register B bit 1	Default LOS assert level of 18 mVpp is used
LOSB0	LOS assert level register B bit 0 (LSB)	Register LOSB is used when RATE1 = 0 and RATE0 = 1
LOSCSEL	Register LOSC select bit 7 (MSB)	LOS assert level register C
LOSC6	LOS assert level register C bit 6	LOSCSEL = 1
LOSC5	LOS assert level register C bit 5	Content of register C bits 6 to 0 is used to select the LOS assert level
LOSC4	LOS assert level register C bit 4	Minimum LOS assert level for 0000000
LOSC3	LOS assert level register C bit 3	Maximum LOS assert level for 1111111
LOSC2	LOS assert level register C bit 2	LOSCSEL = 0
LOSC1	LOS assert level register C bit 1	Default LOS assert level of 26 mVpp is used
LOSC0	LOS assert level register C bit 0 (LSB)	Register LOSC is used when RATE1 = 1 and RATE0 = 1
LOSDSEL	Register LOSD select bit 7 (MSB)	LOS assert level register D
LOSDSLL LOSD6	LOS assert level register D bit 6	LOSDSEL = 1
LOSD5	LOS assert level register D bit 5	Content of register D bits 6 to 0 is used to select the LOS assert level
LOSD3	LOS assert level register D bit 3	Minimum LOS assert level for 0000000
LOSD4	LOS assert level register D bit 4	Maximum LOS assert level for 1111111
LOSD3	LOS assert level register D bit 3	LOSDSEL = 0
LOSD2	LOS assert level register D bit 2	Default LOS assert level of 26 mVpp is used
LOSDI	LOS assert level register D bit 1	Register LOSD is used when RATE1 = 1 and RATE0 = 0 or RATE1 and RATE0
20000		are not connected
SELRATE3	Selected rate setting bit 3	Selected rate setting (read only)
SELRATE2	Selected rate setting bit 2	
SELRATE1	Selected rate setting bit 1	
SELRATE0	Selected rate setting bit 0	
	<b>~</b>	

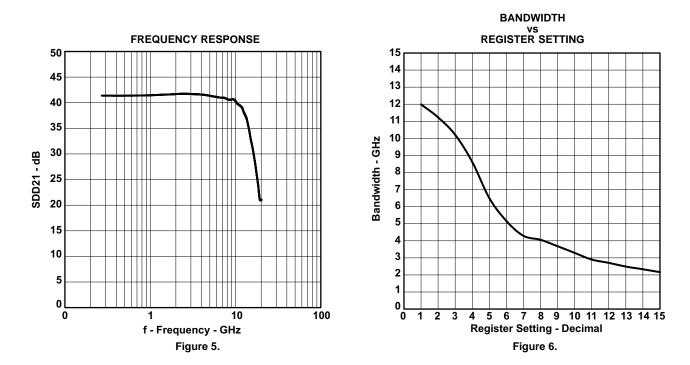


#### Table 19. Register Functionality (continued)

SYMBOL	REGISTER BIT	FUNCTION
SELLOS6	Selected LOS assert level bit 6 (MSB)	Selected LOS assert level (read only)
SELLOS5	Selected LOS assert level bit 5	
SELLOS4	Selected LOS assert level bit 4	
SELLOS3	Selected LOS assert level bit 3	
SELLOS2	Selected LOS assert level bit 2	
SELLOS1	Selected LOS assert level bit 1	
SELLOS0	Selected LOS assert level bit 0 (LSB)	

## **TYPICAL OPERATION CHARACTERISTICS**

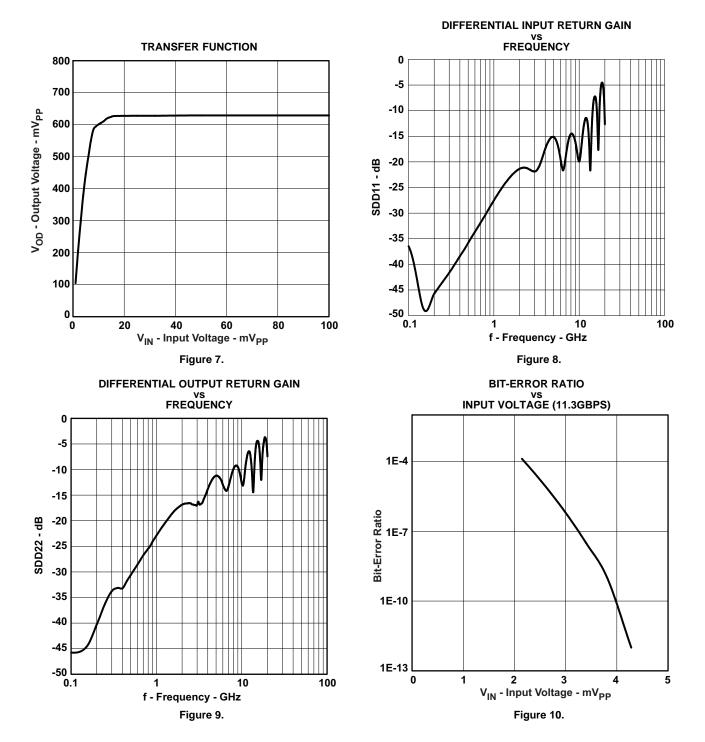
Typical operating condition is at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted.





## **TYPICAL OPERATION CHARACTERISTICS (continued)**

Typical operating condition is at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted.

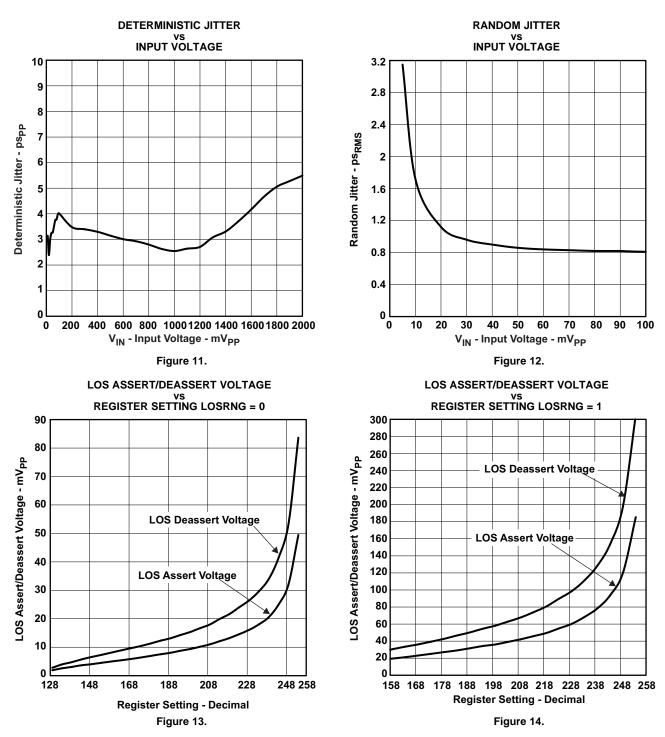


ONET8501P SLLS885-FEBRUARY 2008



## **TYPICAL OPERATION CHARACTERISTICS (continued)**

Typical operating condition is at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted.





## **TYPICAL OPERATION CHARACTERISTICS (continued)**

Typical operating condition is at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted.

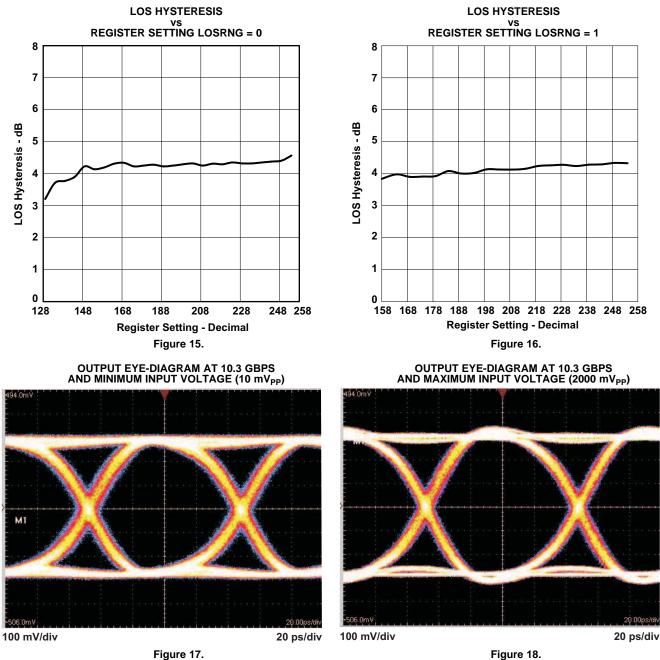


Figure 17.

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## **TYPICAL OPERATION CHARACTERISTICS (continued)**

Typical operating condition is at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C, AMP1 = 0, AMP0 = 1 (Register 3) and maximum bandwidth unless otherwise noted.

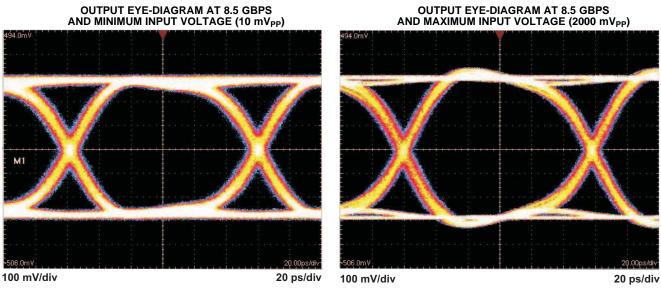


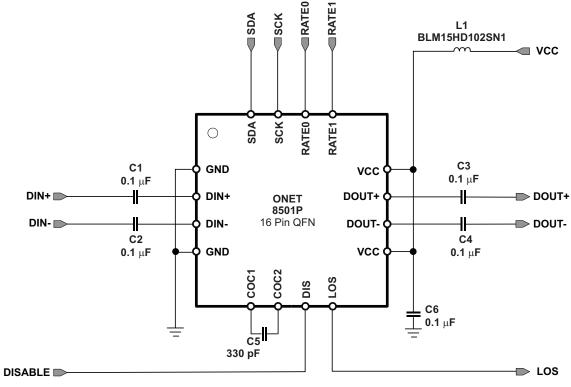
Figure 19.

Figure 20.



## **APPLICATION INFORMATION**

Figure 21 shows a typical application circuit using the ONET8501P.







10-Jun-2014

## **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
ONET8501PRGTR	ACTIVE	QFN	RGT	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 100	850P	Samples
ONET8501PRGTT	ACTIVE	QFN	RGT	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 100	850P	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM

10-Jun-2014

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Il dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ONET8501PRGTR	QFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
ONET8501PRGTR	QFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
ONET8501PRGTT	QFN	RGT	16	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

9-Nov-2016



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ONET8501PRGTR	QFN	RGT	16	3000	367.0	367.0	35.0
ONET8501PRGTR	QFN	RGT	16	3000	336.6	336.6	28.6
ONET8501PRGTT	QFN	RGT	16	250	336.6	336.6	28.6

# **MECHANICAL DATA**



- Quad Flatpack, No-leads (QFN) package configuration. C.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F. Falls within JEDEC MO-220.



# RGT (S-PVQFN-N16)

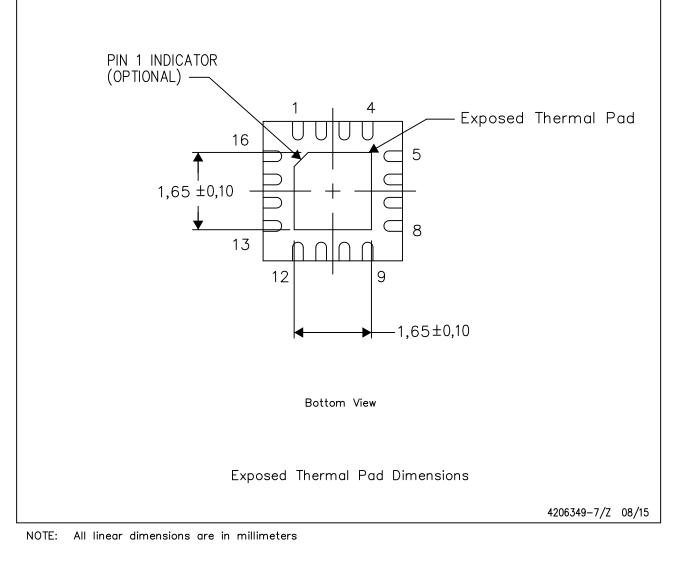
## PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

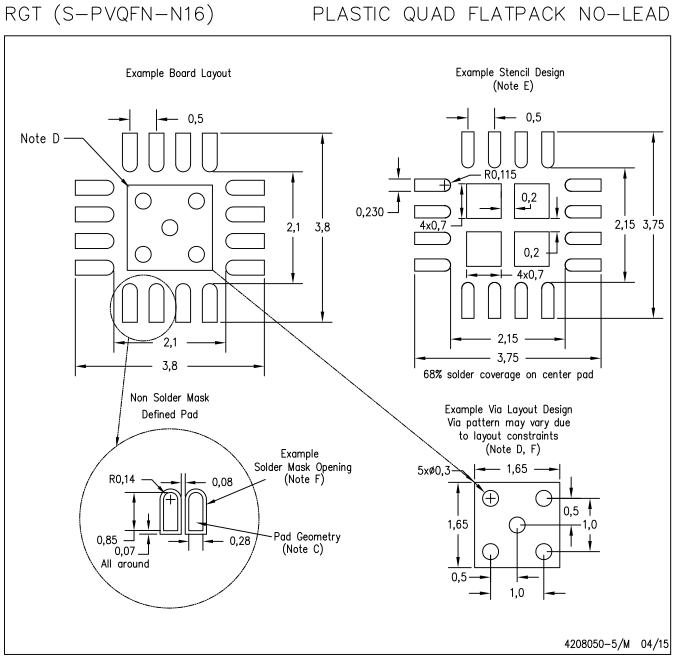
This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.







- NOTES: A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



# RGT (S-PVQFN-N16)

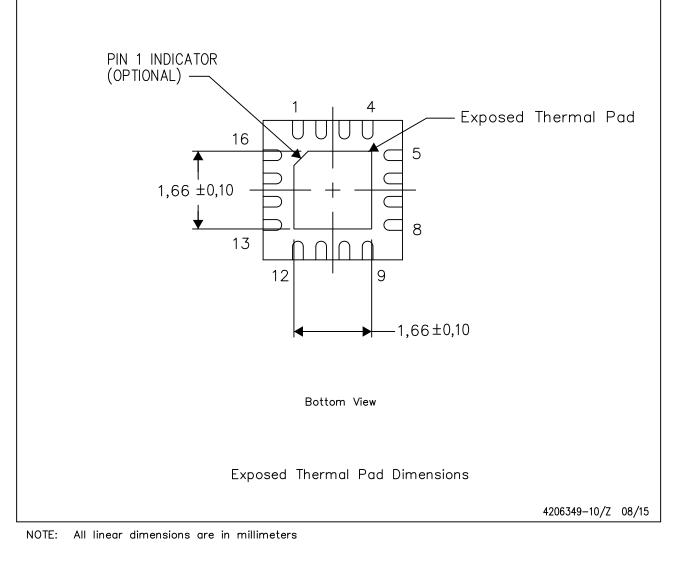
## PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

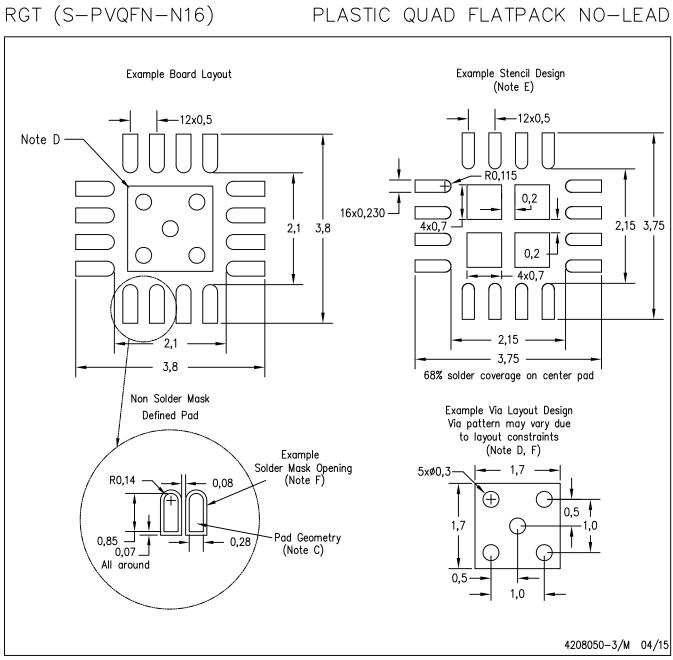
This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

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  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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